2SB1589

Silicon PNP epitaxial planar type

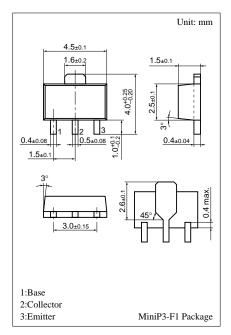
For low-frequency output amplification

Features

- Low collector to emitter saturation voltage V_{CE(sat)}.
- Large collector power dissipation P_C.
- Mini Power type package, allowing downsizing of the equipment and automatic insertion through the tape packing and the magazine packing.

Parameter	Symbol	Ratings	Unit	
Collector to base voltage	V _{CBO}	V _{CBO} -10		
Collector to emitter voltage	V _{CEO}	-10	v	
Emitter to base voltage	V _{EBO}	_7	V	
Peak collector current	I _{CP}	-2	А	
Collector current	I _C	-1.5	А	
Collector power dissipation	P_{C}^{*}	1	W	
Junction temperature	Tj	150	°C	
Storage temperature	T _{stg}	-55 ~ +150	°C	

Absolute Maximum Ratings (Ta=25°C)



Marking symbol : 1U

*	Printed circuit board: Copper foil area of 1cm ² or more, and the board
	thickness of 1.7mm for the collector portion

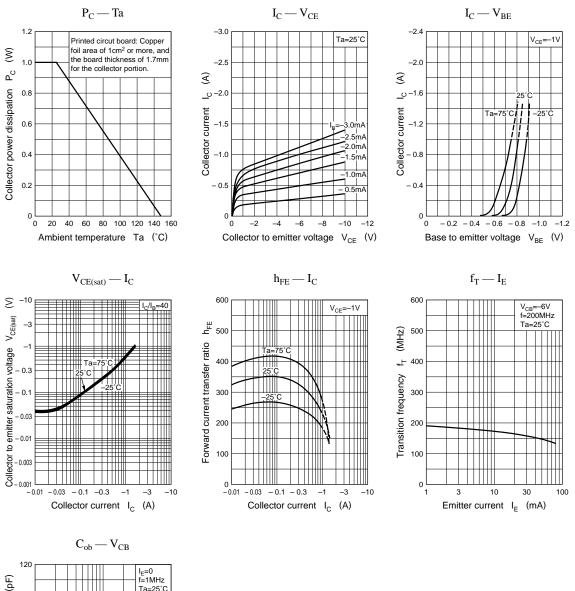
Electrical Characteristics (Ta=25°C)

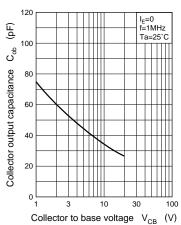
Parameter	Symbol	Conditions	min	typ	max	Unit
Collector cutoff current	I _{CBO}	$V_{CB} = -7V, I_E = 0$			-1	μΑ
Collector to base voltage	V _{CBO}	$I_{C} = -10 \mu A, I_{E} = 0$	-10			v
Collector to emitter voltage	V _{CEO}	$I_C = -1 m A, I_B = 0$	-10			v
Emitter to base voltage	V _{EBO}	$I_{\rm E} = -10 \mu A, I_{\rm C} = 0$	-7			v
Forward current transfer ratio	h _{FE}	$V_{CE} = -1V, I_C = -400 \text{mA}^{*2}$	200		700	
Collector to emitter saturation voltage	V _{CE(sat)}	$I_{\rm C} = -1$ A, $I_{\rm B} = -25$ mA ^{*2}		- 0.24	- 0.35	v
Transition frequency	f _T	$V_{CB} = -6V, I_E = 50mA, f = 200MHz$		190		MHz
Collector output capacitance	C _{ob}	$V_{CB} = -10V, I_E = 0, f = 1MHz$		65		pF
Forward voltage	V_{F}^{*1}	$I_F = -500 \text{mA}$			-1.3	V

*1 Applicable to the built-in diode.

*2 Pulse measurement

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